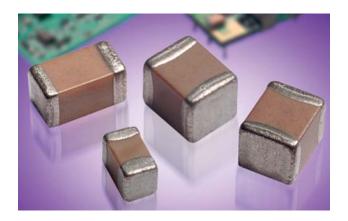
General Specifications





X7R formulations are called "temperature stable" ceramics and fall into EIA Class II materials. X7R is the most popular of these intermediate dielectric constant materials. Its temperature variation of capacitance is within $\pm 15\%$ from -55°C to +125°C. This capacitance change is non-linear.

Capacitance for X7R varies under the influence of electrical operating conditions such as voltage and frequency.

X7R dielectric chip usage covers the broad spectrum of industrial applications where known changes in capacitance due to applied voltages are acceptable.

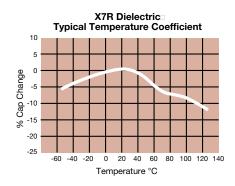
**See FLEXITERM® X7R section

RoHS

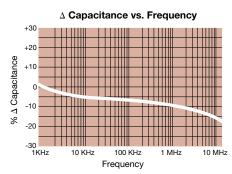
PART NUMBER (see page 2 for complete part number explanation)

0805	<u>5</u>	<u>C</u>	103	<u>M</u>	A	<u>T</u>	2	A
Size (L" × W")	Voltage 4V = 4 6.3V = 6 10V = Z 16V = Y 25V = 3	Dielectric X7R = C	Capacitance Code (In pF) 2 Sig. Digits + Number of Zeros	Capacitance Tolerance $J = \pm 5\%^*$ $K = \pm 10\%$ $M = \pm 20\%$	Failure Rate A = Not Applicable	Terminations T = Plated Ni and Sn 7 = Gold Plated* Z = FLEXITERM®**	Packaging 2 = 7" Reel 4 = 13" Reel 7 = Bulk Cass. 9 = Bulk	Special Code A = Std. Product
	50V = 5 100V = 1 200V = 2			*≤1µF only, contact factory for additional values		*Optional termination	Contact Factory For	

NOTE: Contact factory for availability of Termination and Tolerance Options for Specific Part Numbers. Contact factory for non-specified capacitance values.



500V = 7



Insulation Resistance vs Temperature

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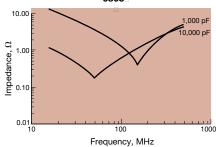
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Multiples

Variation of Impedance with Cap Value Impedance vs. Frequency 1,000 pF vs. 10,000 pF - X7R 0805



10,000 pF - X7R 1206 0805 1210 0.1 100 1000 1000

Variation of Impedance with Chip Size

Impedance vs. Frequency

Impedance vs. Frequency
100,000 pF - X7R

1206
0805
1210

1206
0805
1210

100
Frequency, MHz

Variation of Impedance with Chip Size



Frequency, MHz



Specifications and Test Methods

	ter/Test	X7R Specification Limits	Measuring Conditions					
	perature Range	-55°C to +125°C	Temperature Cycle Chamber					
Capac		Within specified tolerance ≤ 2.5% for ≥ 50V DC rating ≤ 3.0% for 25V DC rating ≤ 3.5% for 25V and 16V DC rating	Freq.: 1.0 kHz ± 10% Voltage: 1.0Vrms ± .2V					
Insulation	Resistance	\leq 5.0% for \leq 10V DC rating 100,000ΜΩ or 1000ΜΩ - μ F, whichever is less	Charge device with rated voltage for 120 ± 5 secs @ room temp/humidity					
Dielectric	Strength	No breakdown or visual defects	Charge device with 300% of rated voltage for 1-5 seconds, w/charge and discharge current limited to 50 mA (max) Note: Charge device with 150% of rated voltage for 500V devices.					
	Appearance	No defects	Deflection: 2mm					
Resistance to	Capacitance Variation	≤ ±12%	Test Time: 3	30 seconds 7 1mm/sec				
Flexure Stresses	Dissipation Factor	Meets Initial Values (As Above)	V					
	Insulation Resistance	≥ Initial Value x 0.3	90 mm					
Solder	rability	≥ 95% of each terminal should be covered with fresh solder	Dip device in eutectic solder at 230 \pm for 5.0 \pm 0.5 seconds					
	Appearance	No defects, <25% leaching of either end terminal						
	Capacitance	≤ ±7.5%	Dip device in eutectic solder at 260°C for 60 seconds. Store at room temperature for 24 ± 2 hours before measuring electrical properties.					
	Variation							
Resistance to	Dissipation Factor	Meets Initial Values (As Above)						
Solder Heat	Insulation							
	Resistance	Meets Initial Values (As Above)						
	Dielectric Strength	Meets Initial Values (As Above)						
	Appearance	No visual defects	Step 1: -55°C ± 2°	30 ± 3 minutes				
	Capacitance Variation	≤ ±7.5%	Step 2: Room Temp	≤ 3 minutes				
Thermal Shock	Dissipation Factor	Meets Initial Values (As Above)	Step 3: +125°C ± 2°	30 ± 3 minutes				
Gildon	Insulation Resistance	Meets Initial Values (As Above)	Step 4: Room Temp	≤ 3 minutes				
	Dielectric Strength	Meets Initial Values (As Above)	Repeat for 5 cycles and measure after 24 ± 2 hours at room temperature					
	Appearance	No visual defects	Z+ ± Z Hours at 100H temperature					
	Capacitance Variation	≤ ±12.5%	Charge device with 1.5 rated voltage (≤ 10V) test chamber set at 125°C ± 2°C					
Load Life	Dissipation Factor	≤ Initial Value x 2.0 (See Above)	for 1000 hou					
	Insulation Resistance	≥ Initial Value x 0.3 (See Above)	Remove from test chamber and stabilize at room temperature for 24 ± 2 hours					
	Dielectric	Meets Initial Values (As Above)	before measuring.					
	Strength	·						
	Appearance	No visual defects	Store in a test chamber set at 85°C ± 2°C/ 85% ± 5% relative humidity for 1000 hours (+48, -0) with rated voltage applied.					
Lecd	Capacitance Variation	≤ ±12.5%						
Load Humidity	Dissipation Factor	≤ Initial Value x 2.0 (See Above)	Remove from chamber and stabilize at room temperature and humidity for 24 ± 2 hours before measuring.					
	Insulation Resistance	≥ Initial Value x 0.3 (See Above)						
	Dielectric Strength	Meets Initial Values (As Above)						







PREFERRED SIZES ARE SHADED

Ш ш SIZE 0101* 0402 0603 0805 1206 0201 Soldering Reflow Only Reflow Only Reflow/Wave Reflow/Wave Reflow/Wave Reflow/Wave Packaging All Paper All Paper All Paper Paper/Embossed Paper/Embossed Paper/Embossed 0.40 ± 0.02 1.00 ± 0.10 (0.040 ± 0.004) 1.60 ± 0.15 (L) Length (0.126 ± 0.008) (0.016 ± 0.0008) (0.024 ± 0.001) (0.063 ± 0.006) (0.079 ± 0.008) 0.50 ± 0.10 (0.020 ± 0.004) 0.20 + 0.02 0.30 ± 0.03 0.81 ± 0.15 (W) Width (0.008 ± 0.0008) (0.011 ± 0.001) (0.032 ± 0.006) (0.049 ± 0.008) (0.063 ± 0.008) 0.20 ± 0.02 (0.008 ± 0.0008) 0.15 ± 0.05 (0.006 ± 0.002) 0.25 ± 0.15 (0.010 ± 0.006) 0.35 ± 0.15 (0.014 ± 0.006) 0.50 ± 0.25 (0.020 ± 0.010) 0.50 ± 0.25 (0.020 ± 0.010) (t) Terminal mm (in.) WVDC 10 16 25 50 10 16 25 50 16 25 50 100 200 16 25 50 100 200 16 25 50 100 200 A A A A Α 470 471 Α 1000 102 1500 3300 4700 Α 6800 M N 104 0.15 0.22 224 N 0.33 N N N N N N N N P 0.68 М М 4.7 475 106 476 WVDC 50 100 200 50 100 200 500 0101 SIZE

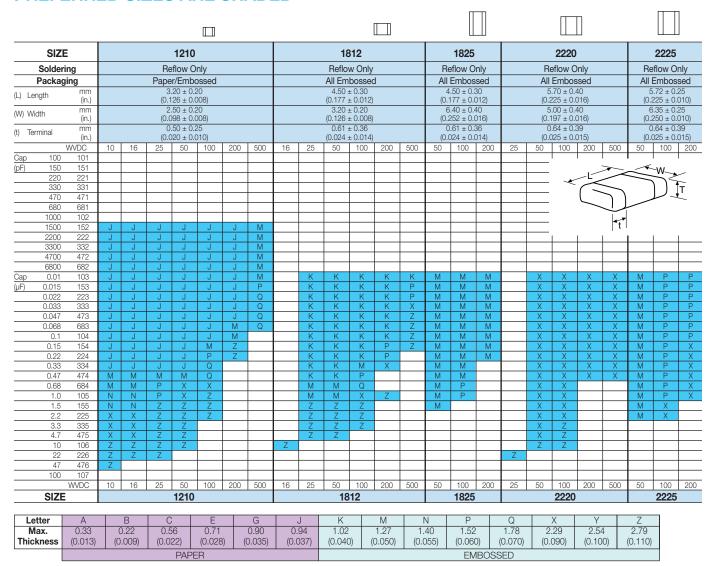
Letter	Α	В	С	Е	G	٦	K	М	N	Р	Q	Χ	Υ	Z
Max.	0.33	0.22	0.56	0.71	0.90	0.94	1.02	1.27	1.40	1.52	1.78	2.29	2.54	2.79
Thickness	(0.013)	(0.009)	(0.022)	(0.028)	(0.035)	(0.037)	(0.040)	(0.050)	(0.055)	(0.060)	(0.070)	(0.090)	(0.100)	(0.110)
	PAPER					EMBOSSED								

NOTE: Contact factory for non-specified capacitance values

*EIA 01005



PREFERRED SIZES ARE SHADED



NOTE: Contact factory for non-specified capacitance values



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NMC0402X7R392K50TRPF NMC0603NPO1R8C50TRPF NMC0603NPO201J50TRPF NMC0603NPO330G50TRPF

NMC0603NPO331F50TRPF NMC0603X5R475M6.3TRPF NMC0805NPO220J100TRPF NMC0805NPO270J50TRPF

NMC0805NPO681F50TRPF NMC0805NPO820J50TRPF NMC1206X7R102K50TRPF NMC1210Y5V105Z50TRPLPF NMC
L0402NPO7R0C50TRPF NMC-L0603NPO2R2B50TRPF NMC-P1206X7R103K1KVTRPLPF NMC-Q0402NPO8R2D200TRPF

C1206C101J1GAC C1608C0G2A221J C1608X7R1E334K C2012C0G2A472J 2220J2K00562KXT KHC201E225M76N0T00

1812J2K00332KXT CCR06CG153FSV CDR14BP471CJUR CDR31BX103AKWR CDR33BX683AKUS CGA2B2C0G1H010C

CGA2B2C0G1H040C CGA2B2C0G1H050C CGA2B2C0G1H060D CGA2B2C0G1H070D CGA2B2C0G1H120J CGA2B2C0G1H151J

CGA2B2C0G1H1R5C CGA2B2C0G1H2R2C CGA2B2C0G1H390J CGA2B2C0G1H391J CGA2B2C0G1H3R3C CGA2B2C0G1H680J

CGA2B2C0G1H6R8D